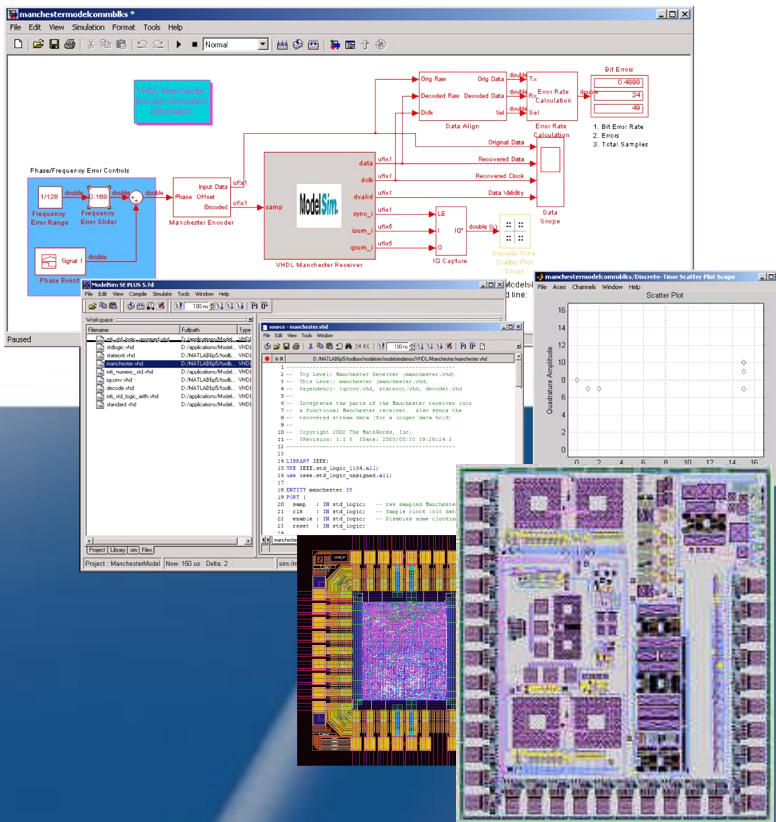


Model-Based Embedded System Design



Pieter J. Mosterman

Senior Research Scientist
The MathWorks, Inc.

Agenda

- **Introduction**
- **Embedded Systems Design**
- **Demo**
- **A Design Activity**
 - **Dynamic Voltage Scaling**
- **Summary**

What is the problem?

- **“Hardware verification is itself become more challenging. Verification times have increased with rising gate count and as overall design complexity grows. According to a survey by Collett International Research in 2002 only 39% of designs were bug free at first silicon, while 60% contained logic or functional flaws. More than 20% required 3 or more silicon spins. A Collett survey also showed that nearly 50% of total engineering time was spent in verification.”**
- **Hardware/Software Co-verification by Dr. Jack Horgan
http://www.edacafe.com/magazine/index.php?newsletter=1&run_date=29-Mar-2004**

What are the pains?

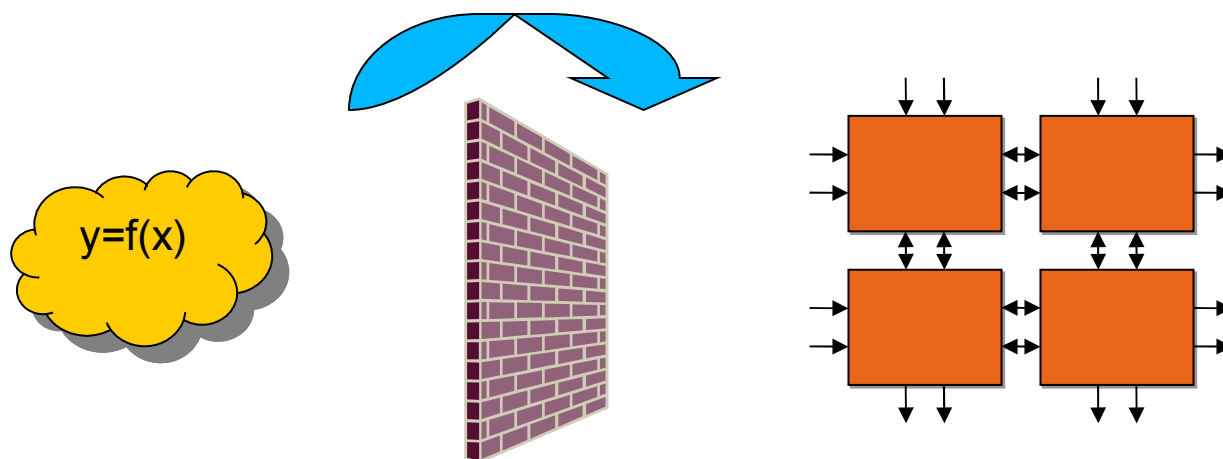
1. **Time and effort to verify a design:** As designs get more complex, the test benches are an order of magnitude more complex, and **consume 40-60% of project resources.**
 - Test bench HDL code will **not** be synthesized – i.e., will not be a part of the shipping product – “throw-away” code
 - HDL test benches need to run in HDL simulators, and HDL simulators are **extremely** slow
2. **Time and effort to construct and maintain test benches:** For **each line of HDL design code** in a design, a user typically **needs 10 lines of HDL test bench code to simulate, test, and verify that 1 line** of HDL code.
 - Constructing a test bench in a textual language is at least as complex as the original design itself
 - Maintaining the test bench from one generation of a design to the next is very resource-intensive

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What are the pains?

- Engineers need to verify that ASIC/FPGA implementations correctly match their system specifications



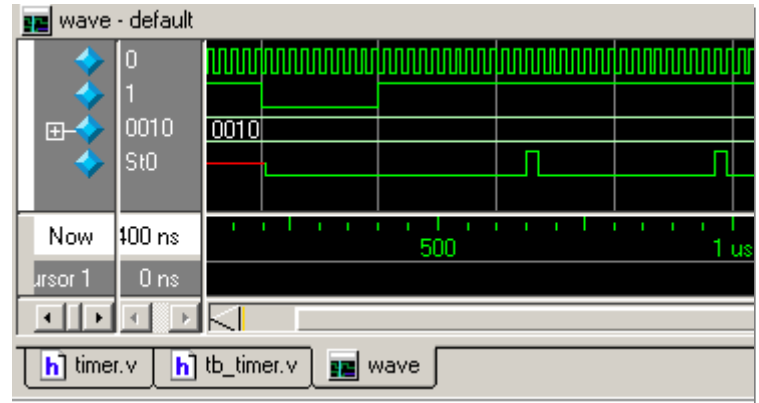
I/O vectors,
functional specification

ASIC/FPGA design flow begins in HDL

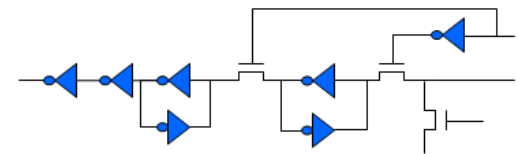
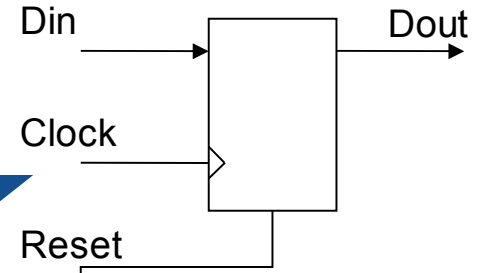
```

1 //Verilog Model of a D Flip Flop
2 module flipflop (dout, din, clock, reset);
3   output dout;
4   input  din, clock, reset;
5
6   reg dout;
7
8   always @(posedge clock)
9     begin
10      if (reset)
11        dout <= 1'b0;
12      else
13        dout <= din;
14    end
15 endmodule //flipflop
    
```

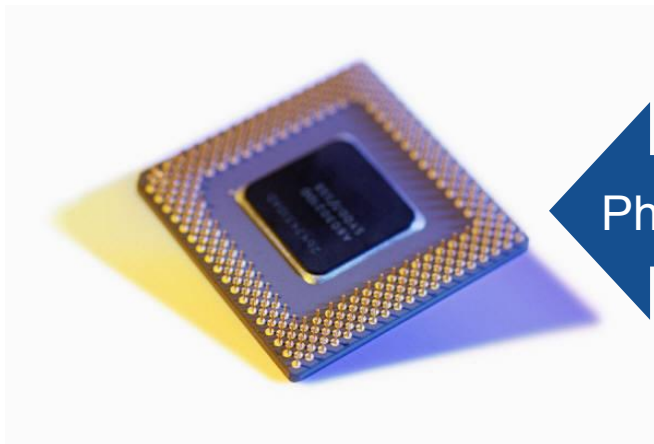
Simulate RTL



Synthesis

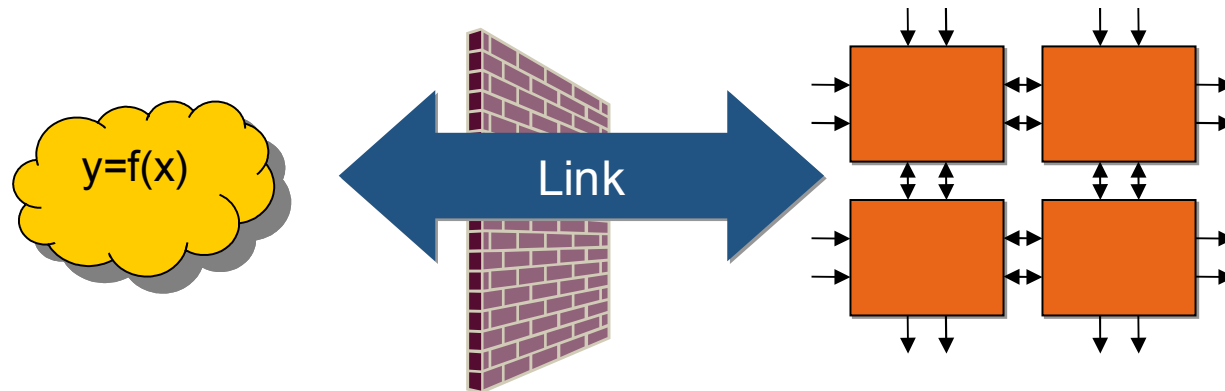


Physical Design



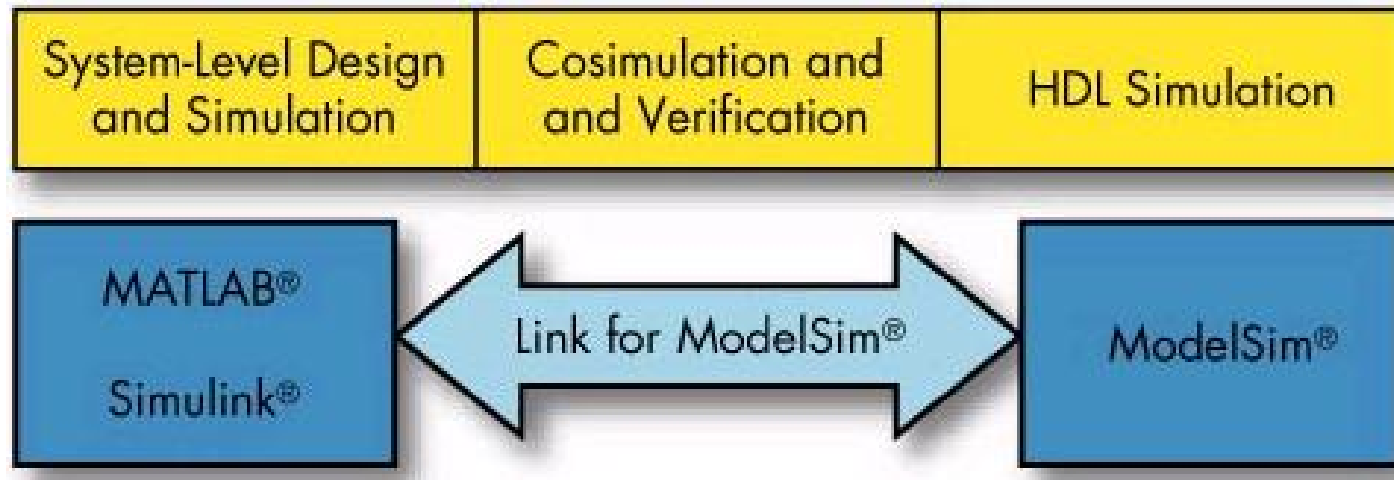
What are the solutions?

- Engineers need to verify that ASIC/FPGA implementations correctly match their system specifications



- Using co-simulation with a cycle accurate simulator, these engineers can analyze hardware components at a system level

Link for ModelSim makes system-level hardware verification possible



- **Fast and bidirectional** cosimulation interface between MATLAB and Simulink, and ModelSim

Agenda

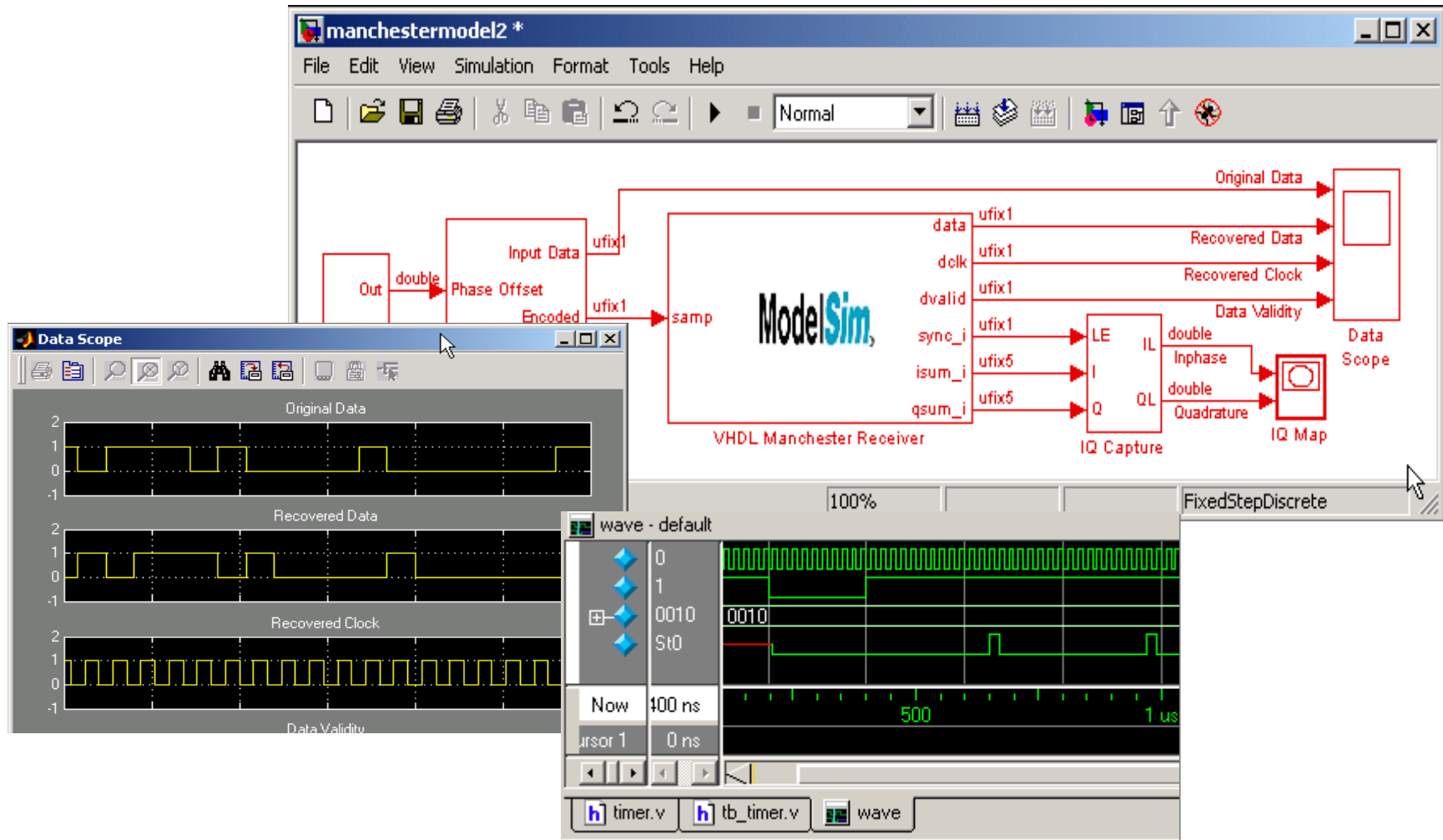
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Demo



- **Edge detection demo**
 - **Design space exploration using floating point**
 - **Conversion to fixed point**
 - **Elaboration to facilitate streaming data**
 - **Co-simulate with HDL**

Simulink co-simulation



Link for ModelSim allows engineers to share models instead of I/O vectors.

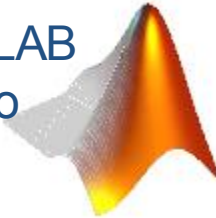
- **The HDL is verified in the context of an entire system and not just as a stand-alone component**
- **System performance metrics, e.g. Packet Error rate (PER), Bit Error Rate (BER), Signal to Noise (S/N) ratio can be measured**

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Dynamic Voltage Scaling

Live
MATLAB
Demo



- **Simulate AT90S8535 microcontroller**
- **Dynamic Voltage Scaling (DVS) based on online gradient estimation**
 - **Infinitesimal perturbation analysis (IPA)**
- **Average cost per job**
 - $J(\theta) = w P(\theta) + S(\theta)$
 - $J(\theta) = w c_2 [V_t / (1 - c_1/\theta)]^2 + S(\theta)$
 - θ , average service time; w , weighting; P , average energy consumption; S , average system time for a job; c_1 and c_2 , device constants; V_t , minimum input voltage

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Summary

- **Integrate system level design with implementation**
 - **Cycle accurate simulation**
- **No duplication of testbench design effort**
- **Analysis of system level properties**